

<b>Notice of References Cited</b>	Application/Control No. 09/412,558	Applicant(s)/Patent Under Reexam Hwang et al.
	Examiner S. Devi, Ph.D.	Art Unit 1645

**U.S. PATENT DOCUMENTS**

	Document Number Country Code-Number-Kind Code	Date MM-YYYY <sup>1</sup>	Name	Classification <sup>2</sup>
A				
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**FOREIGN PATENT DOCUMENTS**

	Document Number Country Code-Number-Kind Code	Date MM-YYYY <sup>1</sup>	Country	Name	Classification <sup>2</sup>
N	EP 0 406 029 A1	02/01/91	Europe	Burnie et al.	----
O					
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**NON-PATENT DOCUMENTS**

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